## In the Claims

This listing of claims will replace all prior versions and listings of claims in the application:

- 1 1. (Original) A method of operating an integrated circuit 2 including read accessible memory comprising the steps of:
- 3 testing memory read operations beginning at a maximum speed at
- 4 successively slower speeds until all memory reads pass;
- determining memory read program bits for a highest memory speed passing the memory read tests; and
- 7 programming write once bits according to determined memory
- 8 read program bits.
- 2. (Original) The method of claim 1 further comprising the
  2 steps of:
- 3 preliminary soft programming determined bits; and
- 4 testing non-memory portions of the integrated circuit using
- 5 soft programmed determined memory read program bits.
- 3. (Original) The method of claim 1 wherein:
- 2 said step of programming write once bits includes
- 3 applying program voltages to the bits,
- 4 testing the write once bits to determine achieved
- 5 programming, and
- 6 repeating applying program voltages and testing the write
- 7 once bits until the testing confirms correct write once bit
- programming.
- 1 4. (Currently Amended) The method of claim 1 wherein
- 2 programming of eFuse write once bits includes:
- 3 merging of programming of write once bits for memory read
- 4 speed with programming write once bits not related to memory speed.

- 5. (Original) The method of claim 4 wherein:
- 2 the write once bits not related to memory speed include a
- 3 specific die-identification bit code.
- 1 6. (Original) The method of claim 4 wherein:
- 2 the write once bits not related to memory read speed include
- 3 write once bits for memory redundancy programming.
- 1 7. (Original) The method of claim 4 wherein:
- 2 the write once bits not related to memory read speed include
- 3 write once bits for control of programmable logic functions.
- 1 8. (Original) The method of claim 1, wherein the read
- 2 accessible memory is write accessible, further comprising:
- 3 testing memory write operations beginning at a maximum speed
- 4 at successively slower speeds until all memory reads pass;
- 5 determining memory write program bits for a highest memory
- 6 speed passing the memory write tests; and
- 7 said step of programming write once bits according to
- 8 determined memory read program bits further includes programming
- 9 write once bits according determined memory write program bits.
- 9. (Original) A method of operating an integrated circuit
- 2 including write accessible memory comprising the steps of:
- 3 testing memory write operations beginning at a maximum speed
- 4 at successively slower speeds until all memory writes pass;
- 5 determining memory write program bits for a highest memory
- 6 speed passing the memory write tests; and
- 7 programming write once bits according to determined memory
- 8 write program bits.

- 1 10. (Original) The method of claim 9 further comprising the 2 steps of:
- 3 preliminary soft programming determined write once bits; and
- 4 testing non-memory portions of the integrated circuit using
- 5 soft programmed determined memory write program bits.
- 1 11. (Original) The method of claim 9 wherein:
- 2 said step of programming write once bits includes
- 3 applying program voltages to the write once bits,
- 4 testing the write once bits to determine achieved
- 5 programming, and
- 6 repeating applying program voltages and testing the write
- 7 once bits until the testing confirms correct write once bit
- 8 programming.
- 1 12. (Original) The method of claim 9 wherein:
- 2 programming of write once bits includes merging of programming
- 3 of write once bits for memory write speed with programming write
- 4 once bits not related to memory speed.
- 1 13. (Original) The method of claim 12 wherein:
- 2 the write once bits not related to memory write speed include
- 3 a specific die-identification bit code.
- 1 14. (Original) The method of claim 12 wherein:
- 2 the write once bits not related to memory write speed include
- 3 write once bits for memory redundancy programming.
- 1 15. (Original) The method of claim 12 wherein:
- 2 the write once bits not related to memory write speed include
- 3 write once bits for control of programmable logic functions.

## 16 to 18. (Canceled)

- 1 19. (New) The method of claim 1 further comprising the steps 2 of:
- . 3 operating memory read operations of the read accessible memory
  - 4 at a speed corresponding to the programmed write once memory read
  - 5 program bits.
  - 1 20. (New) The method of claim 8 further comprising the steps
  - 2 of:
  - 3 operating memory write operations of the read accessible
  - 4 memory at a speed corresponding to the programmed write once memory
  - 5 write program bits.
  - 1 21. (New) The method of claim 9 further comprising the steps
  - 2 of:
  - 3 operating memory write operations of the write accessible
  - 4 memory at a speed corresponding to the programmed write once memory
  - 5 write program bits.